

N- and P-Channel Enhancement Mode Power MOSFET

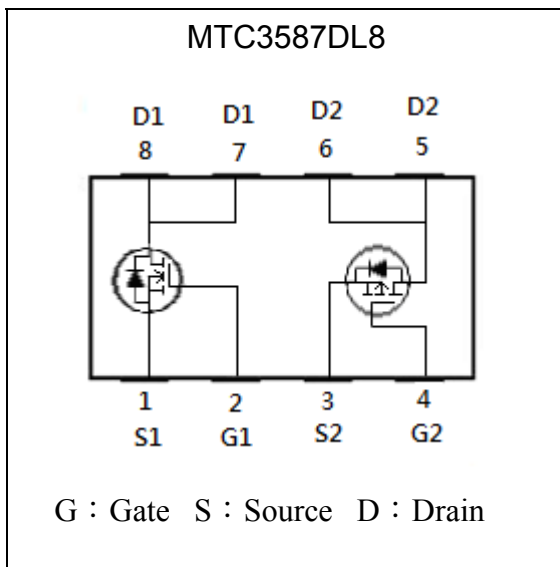
MTC3587DL8

	N-CH	P-CH
BV_{DSS}	20V	-20V
$I_D @ T_A=25^\circ C$	4.9A($V_{GS}=4.5V$)	-3.9A($V_{GS}=-4.5V$)
$R_{DSON(TYP.)}$	32m Ω ($V_{GS}=4.5V$)	50m Ω ($V_{GS}=-4.5V$)
	43m Ω ($V_{GS}=2.5V$)	62m Ω ($V_{GS}=-2.5V$)
	62m Ω ($V_{GS}=1.8V$)	81m Ω ($V_{GS}=-1.8V$)

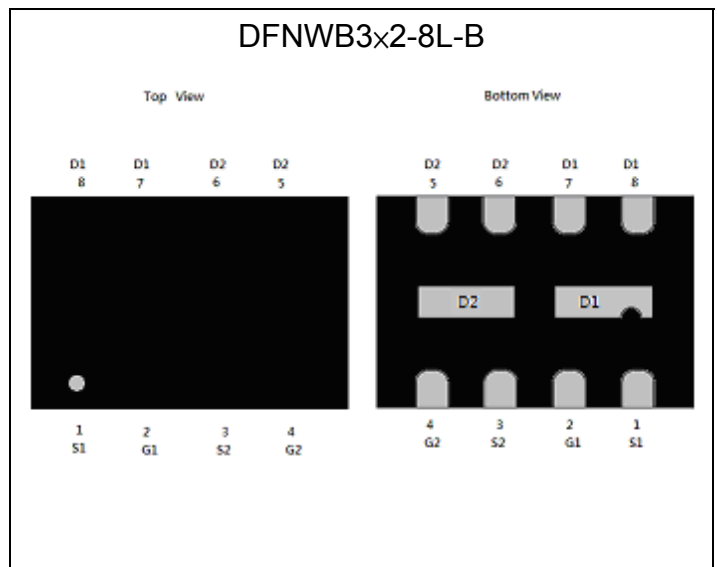
Features

- Simple drive requirement
- Low gate charge
- Low on-resistance
- Fast switching speed
- Pb-free lead plating and halogen-free package

Equivalent Circuit

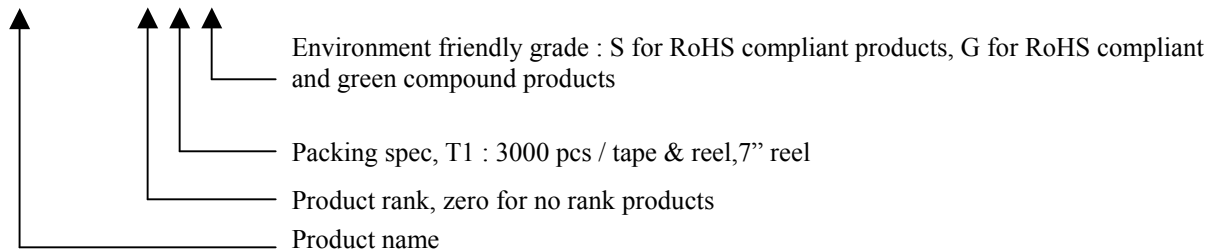


Outline



Ordering Information

Device	Package	Shipping
MTC3587DL8-0-T1-G	DFNWB3x2-8L-B (Pb-free lead plating and halogen-free package)	3000 pcs / tape & reel





Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Limits		Unit
		N-channel (Q1)	P-channel (Q2)	
Drain-Source Breakdown Voltage	BV _{DSS}	20	-20	V
Gate-Source Voltage	V _{GS}	±8	±8	
Continuous Drain Current @T _A =25 °C (Note 1)	I _D	4.9	-3.9	A
Continuous Drain Current @T _A =70 °C (Note 1)		3.9	-3.1	
Pulsed Drain Current (Note 2)	I _{DM}	30	-23	
Maximum Power Dissipation @T _A =25°C (Note 1)	P _D	1.5		W
Maximum Power Dissipation @T _A =70°C (Note 1)		0.96		
Operating Junction and Storage Temperature	T _j , T _{stg}	-55~+150		°C

Thermal Performance

Parameter	Symbol	Limit	Unit
Thermal Resistance, Junction-to-Ambient (Note 1)	R _{θJA}	85	°C/W
Thermal Resistance, Junction-to-Case	R _{θJC}	25	

Note : 1.Surface mounted on 1 in² copper pad of FR-4 board, t≤5 sec.
 2.Pulse width limited by maximum junction temperature.

N-Channel Electrical Characteristics (T_j=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	20	-	-	V	V _{GS} =0V, I _D =250μA
ΔBV _{DSS} /ΔT _j	-	12	-	mV/°C	Reference to 25°C, I _D =250μA
V _{GS(th)}	0.5	-	1.2	V	V _{DS} =V _{GS} , I _D =250μA
I _{GSS}	-	-	±100	nA	V _{GS} =±8V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =20V, V _{GS} =0V
	-	-	10		V _{DS} =16V, V _{GS} =0V, T _j =70°C
*R _{DS(ON)}	-	32	45	mΩ	V _{GS} =4.5V, I _D =4.4A
	-	43	70		V _{GS} =2.5V, I _D =4.1A
	-	62	120		V _{GS} =1.8V, I _D =1.9A
*G _{FS}	-	6.2	-	S	V _{DS} =5V, I _D =3A
Dynamic					
C _{iss}	-	404	-	pF	V _{DS} =15V, V _{GS} =0V, f=1MHz
C _{oss}	-	48	-		
C _{rss}	-	52	-		
*t _{d(ON)}	-	5	-	ns	V _{DS} =10V, I _D =4.4A, V _{GS} =4.5V, R _G =2.5Ω
*t _r	-	16.6	-		
*t _{d(OFF)}	-	24.4	-		
*t _f	-	7.6	-		



*Qg	-	5.9	-	nC	V _{DS} =10V, I _D =4.4A, V _{GS} =4.5V
*Qgs	-	0.9	-		
*Qgd	-	1.5	-		
Source-Drain Diode					
*V _{SD}	-	0.85	1.2	V	V _{GS} =0V, I _S =2.5A
*trr	-	5.8	-	ns	I _F =1.7A, V _{GS} =0V, dI _F /dt=100A/μs
*Qrr	-	1.8	-	nC	

*Pulse Test : Pulse Width ≤300μs, Duty Cycle ≤2%

P-Channel Electrical Characteristics (T_j=25°C, unless otherwise specified)

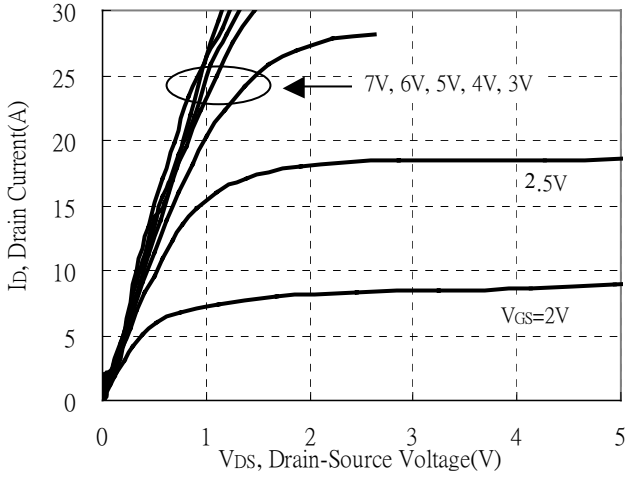
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	-20	-	-	V	V _{GS} =0V, I _D =-250μA
ΔBV _{DSS} /ΔT _j	-	-13	-	mV/°C	Reference to 25°C, I _D =-250μA
V _{GS(th)}	-0.5	-	-1.2	V	V _{DS} =V _{GS} , I _D =-250μA
I _{GSS}	-	-	±100	nA	V _{GS} =±8V, V _{DS} =0V
I _{DSS}	-	-	-1	μA	V _{DS} =-20V, V _{GS} =0V
	-	-	-25		V _{DS} =-16V, V _{GS} =0V, T _j =70°C
*R _{DSON}	-	50	80	mΩ	V _{GS} =-4.5V, I _D =-3.2A
	-	62	95		V _{GS} =-2.5V, I _D =-2.5A
	-	81	130		V _{GS} =-1.8V, I _D =-1A
*G _{FS}	-	9	-	S	V _{DS} =-5V, I _D =-3A
Dynamic					
C _{iss}	-	1048	-	pF	V _{DS} =-15V, V _{GS} =0V, f=1MHz
C _{oss}	-	74	-		
C _{rss}	-	59	-		
*t _{d(ON)}	-	11.6	-	ns	V _{DS} =-10V, I _D =-3.2A, V _{GS} =-4.5V, R _G =2.5Ω
*t _r	-	22	-		
*t _{d(OFF)}	-	77.8	-		
*t _f	-	28.2	-		
*Qg	-	11.6	-	nC	V _{DS} =-10V, I _D =-3.2A, V _{GS} =-4.5V
*Qgs	-	1.8	-		
*Qgd	-	2.2	-		
Source-Drain Diode					
*V _{SD}	-	-0.85	-1.2	V	V _{GS} =0V, I _S =-2.5A
*trr	-	7.3	-	ns	I _F =-1.7A, V _{GS} =0V, dI _F /dt=100A/μs
*Qrr	-	2.4	-	nC	

*Pulse Test : Pulse Width ≤300μs, Duty Cycle ≤2%

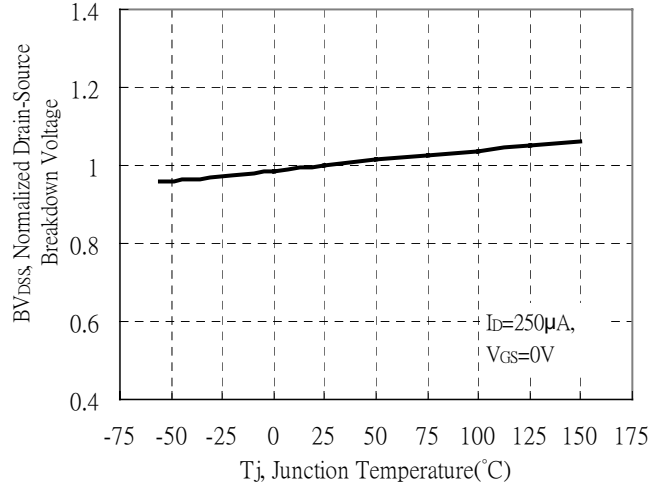


Q1, N-channel Typical Characteristics

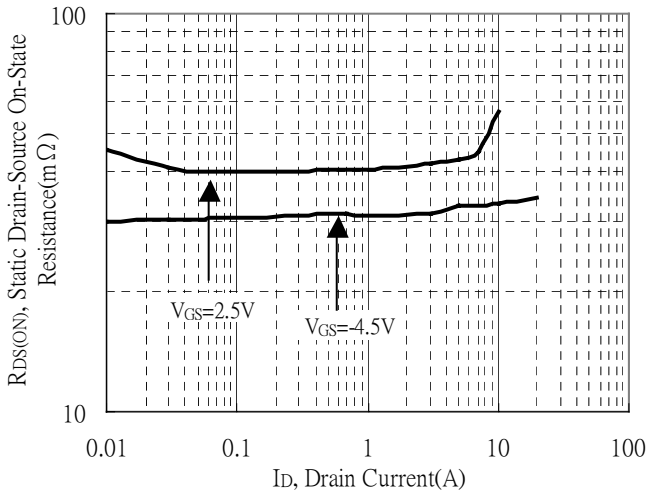
Typical Output Characteristics



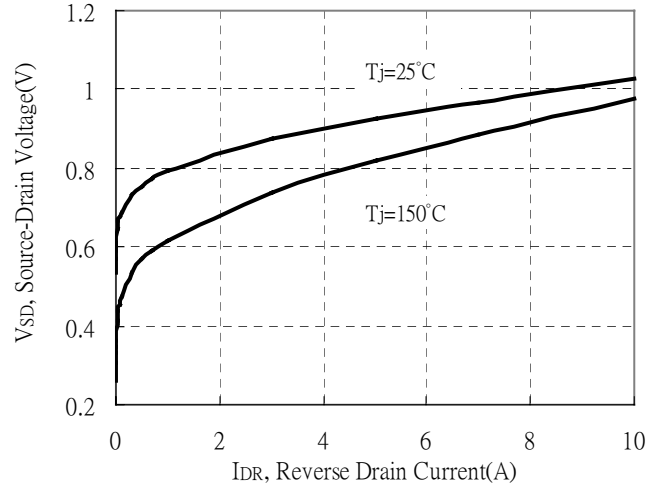
Brekdown Voltage vs Ambient Temperature



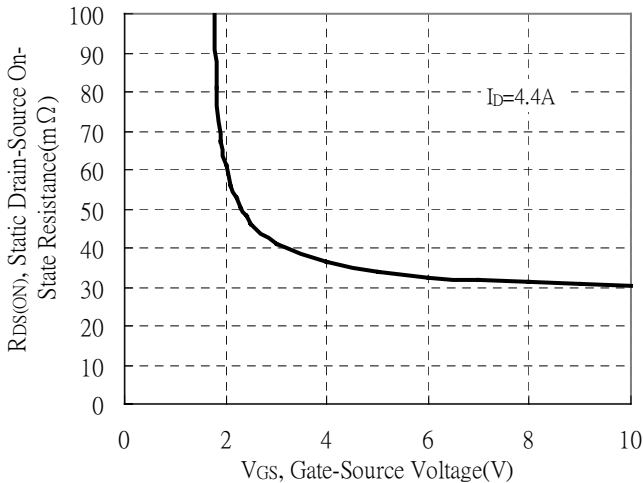
Static Drain-Source On-State resistance vs Drain Current



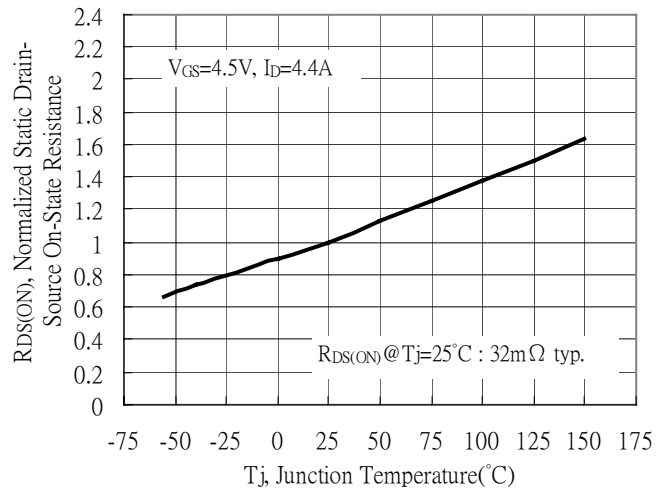
Reverse Drain Current vs Source-Drain Voltage



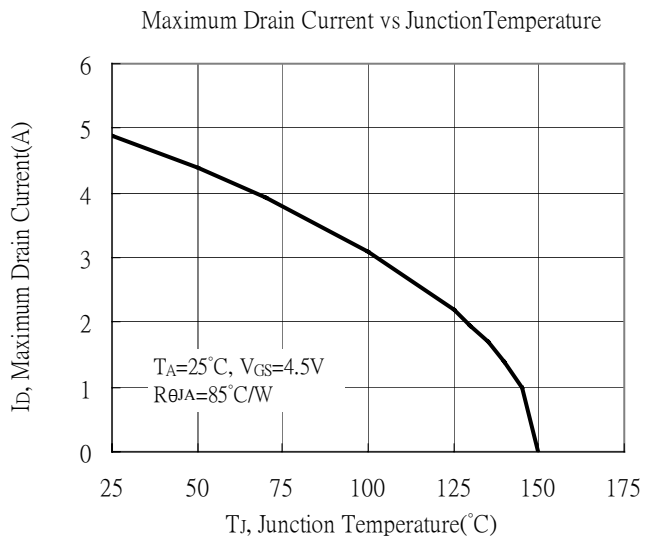
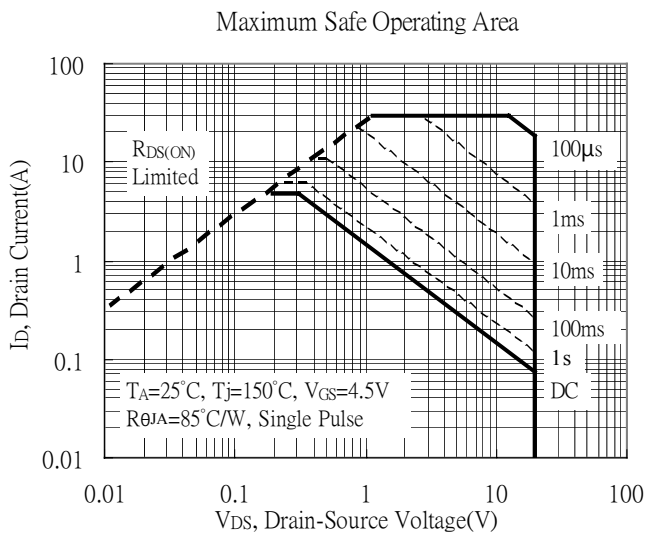
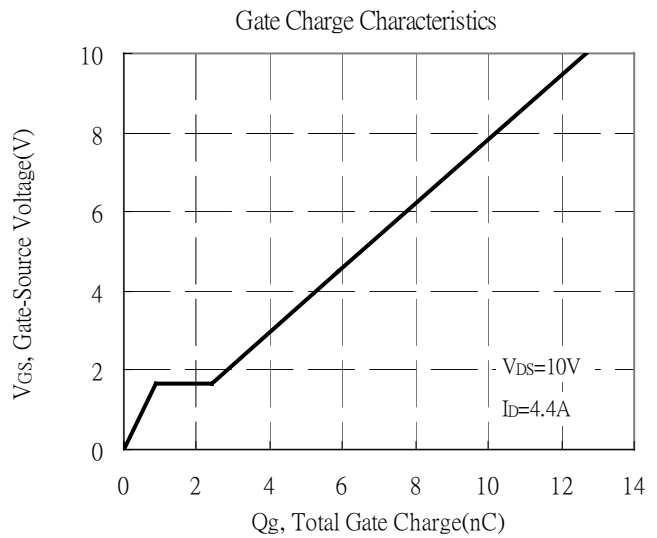
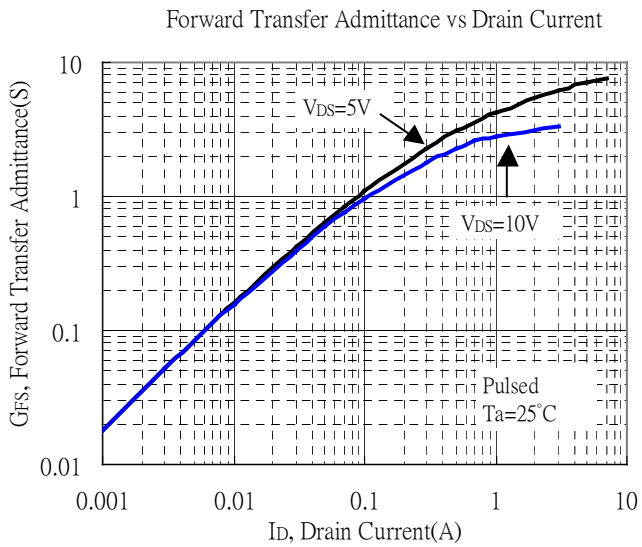
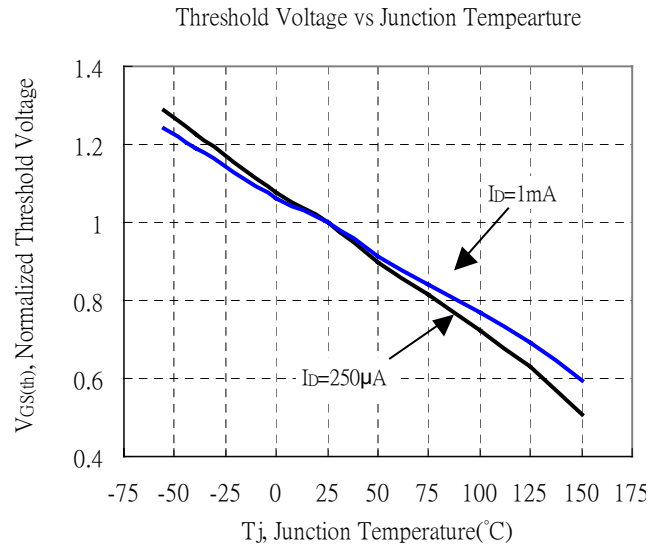
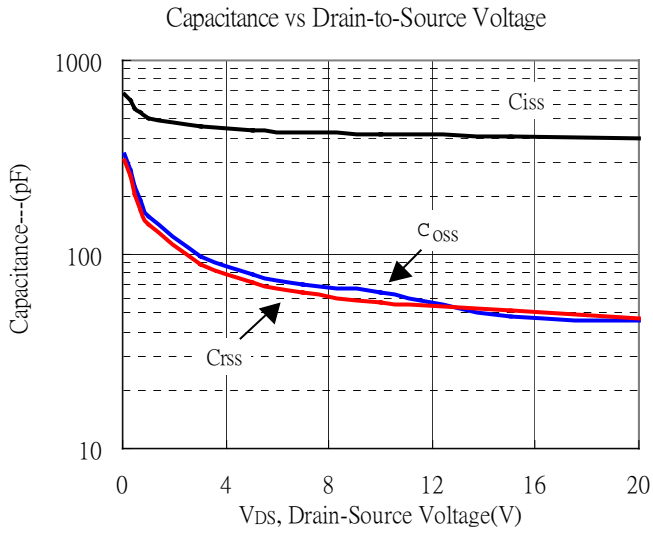
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

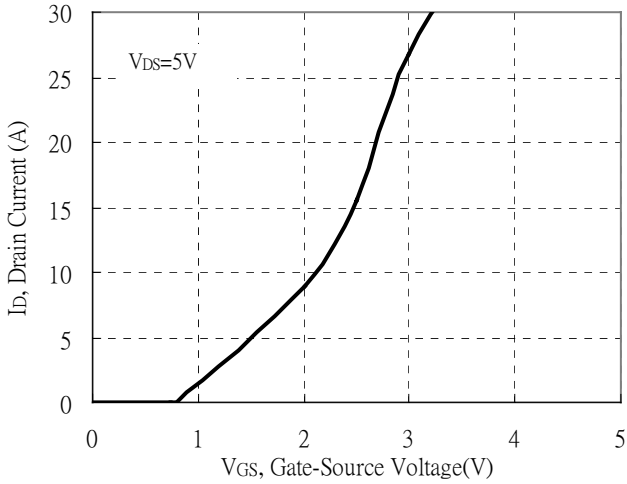


Q1, N-channel Typical Characteristics(Cont.)

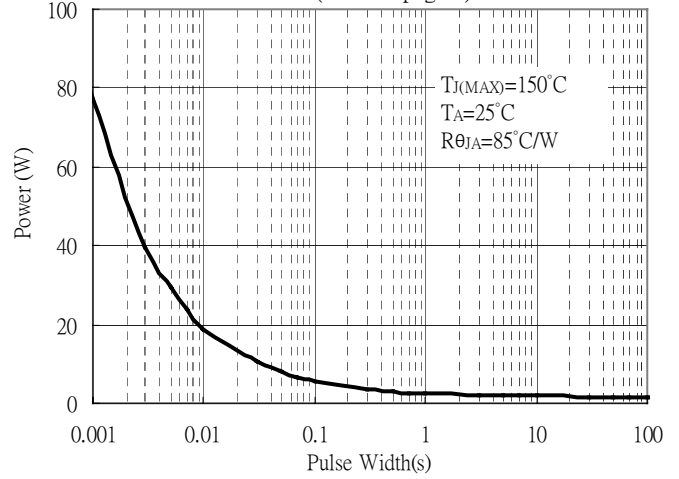


N-channel Typical Characteristics(Cont.)

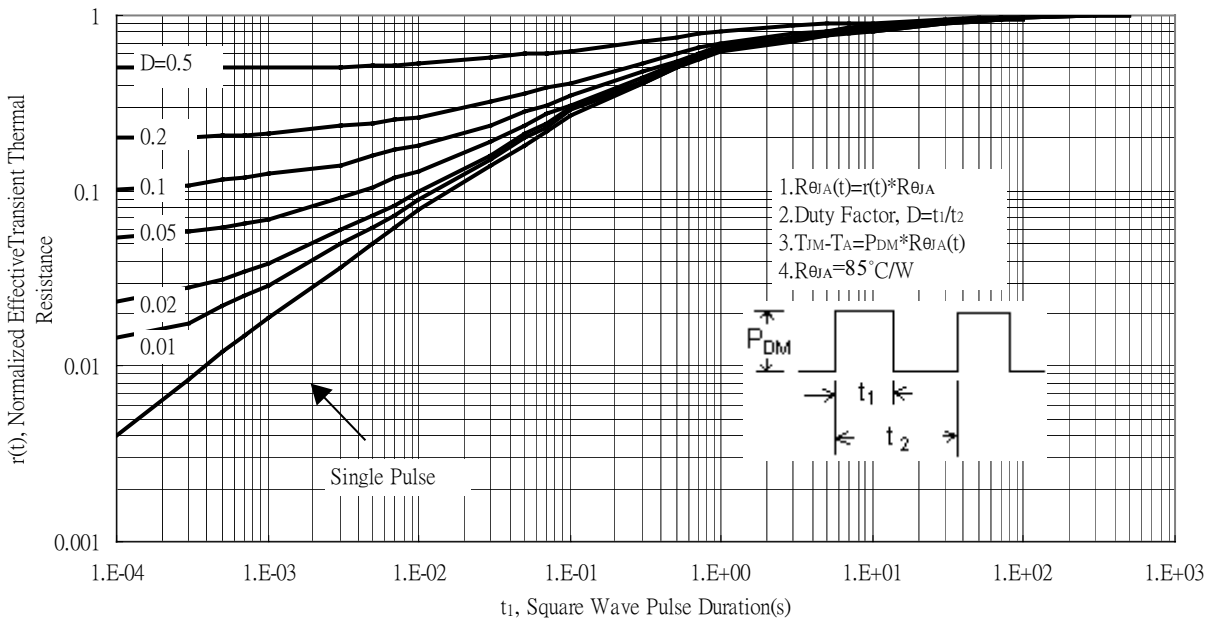
Typical Transfer Characteristics



Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)

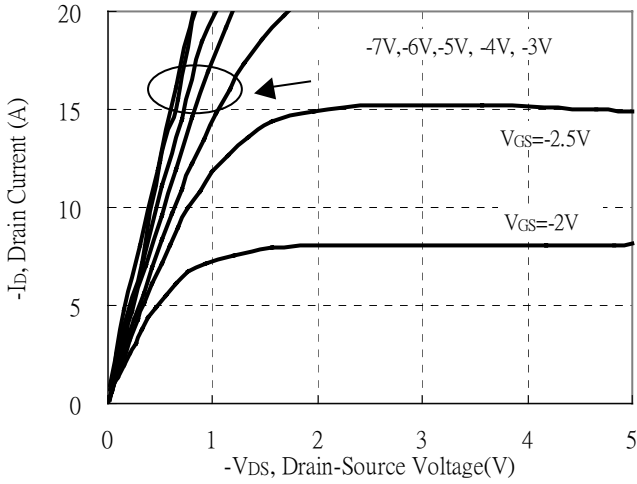


Transient Thermal Response Curves

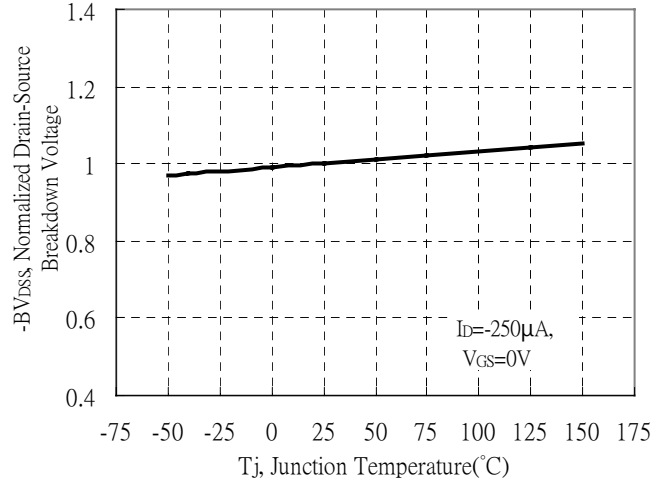


Q2, P-channel Typical Characteristics

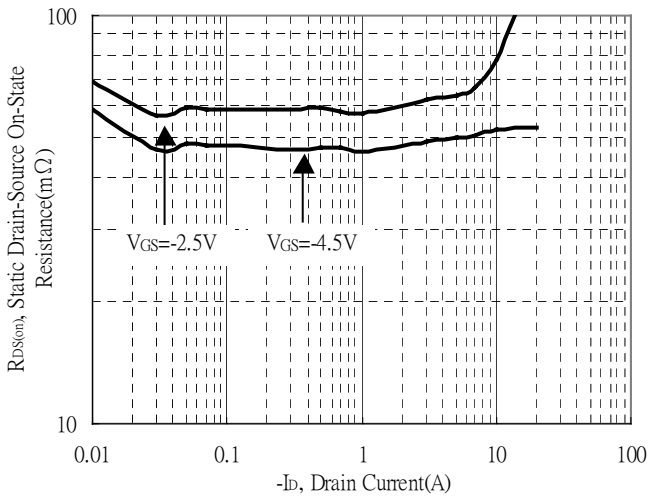
Typical Output Characteristics



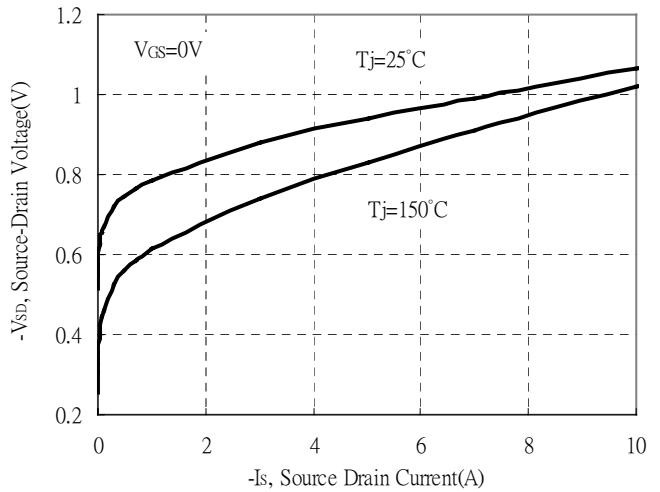
Brekdown Voltage vs Ambient Temperature



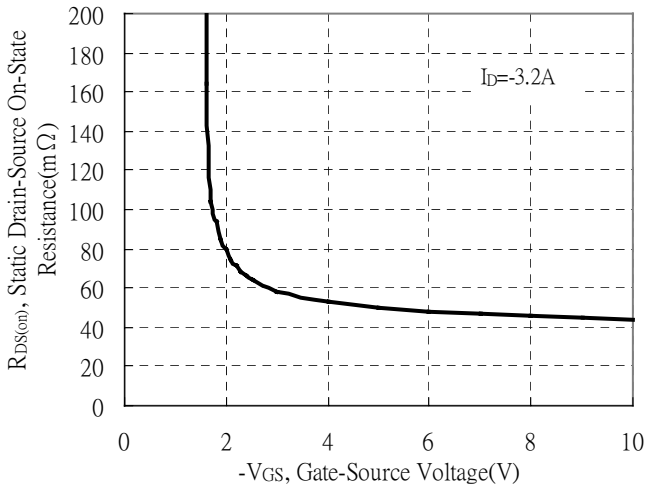
Static Drain-Source On-State resistance vs Drain Current



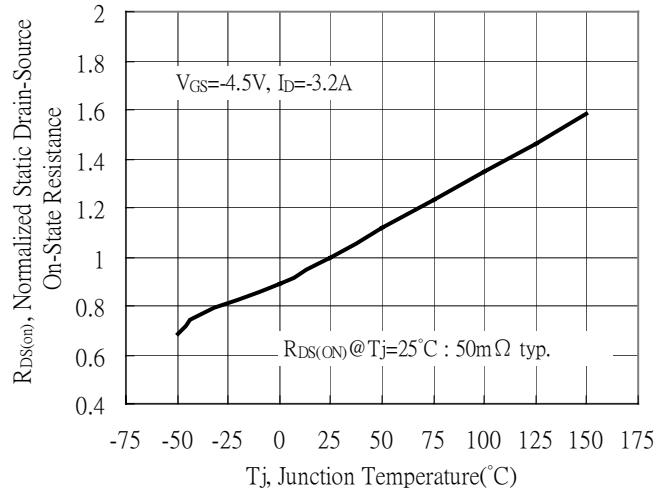
Source Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

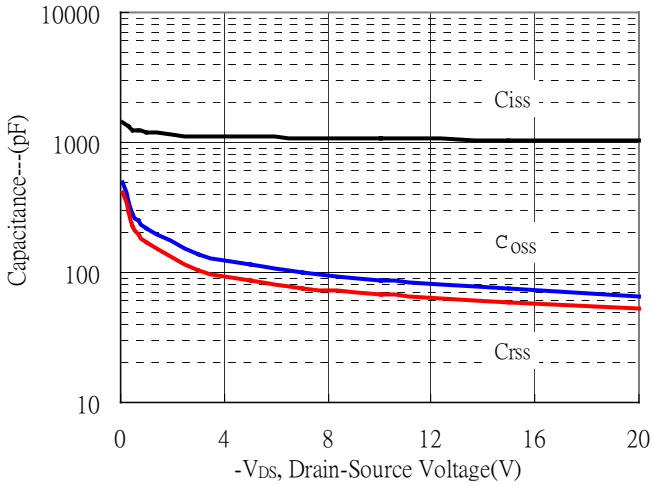


Drain-Source On-State Resistance vs Junction Temperature

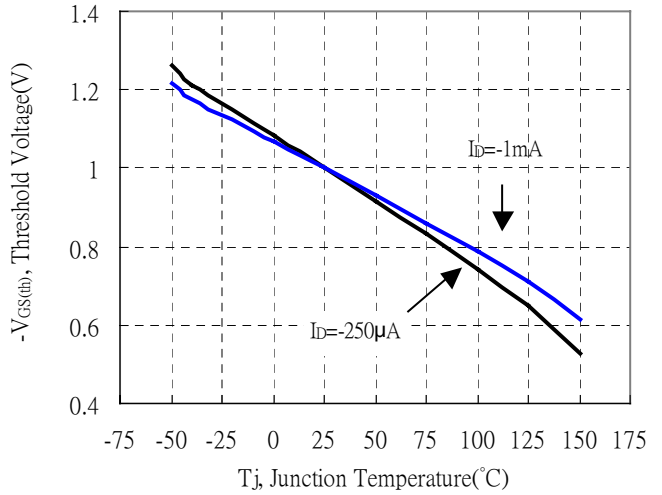


P-channel Typical Characteristics(Cont.)

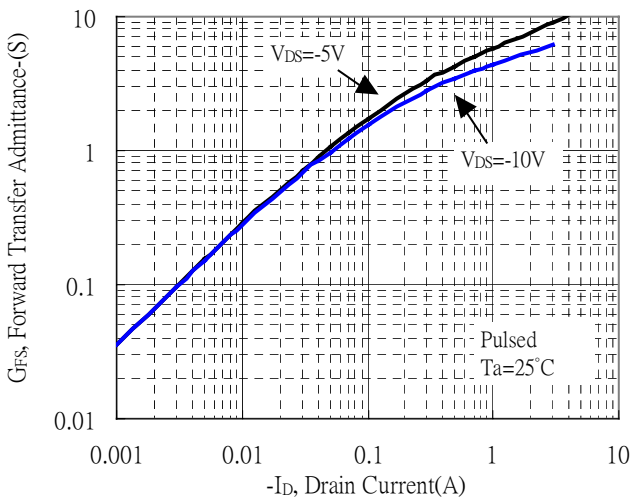
Capacitance vs Drain-to-Source Voltage



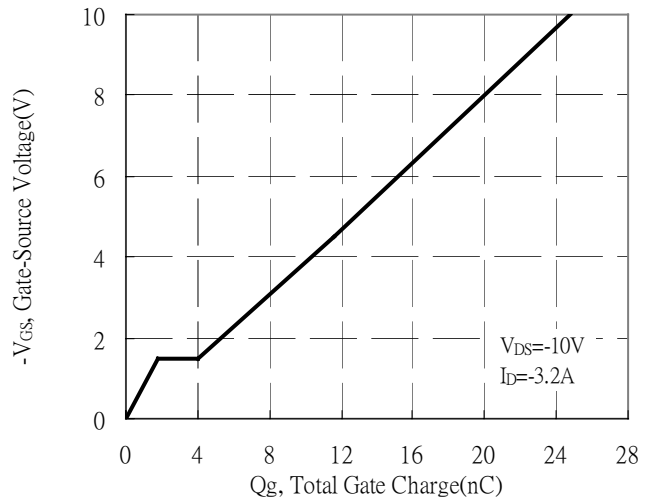
Threshold Voltage vs Junction Temperature



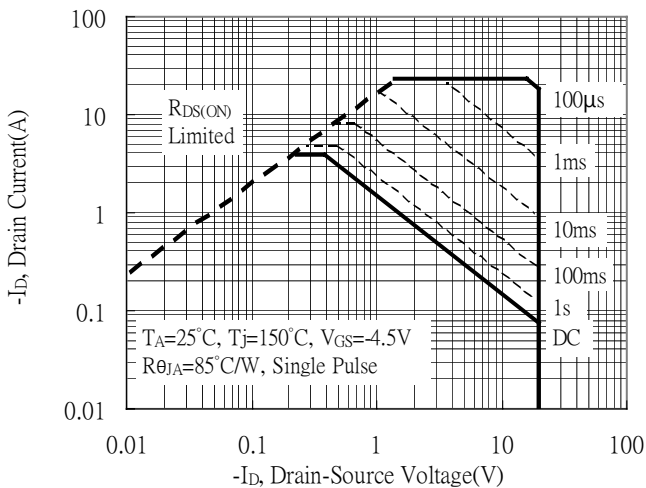
Forward Transfer Admittance vs Drain Current



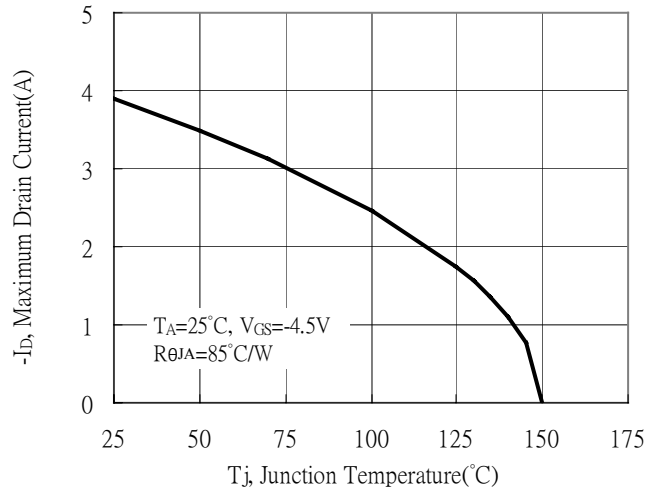
Gate Charge Characteristics



Maximum Safe Operating Area



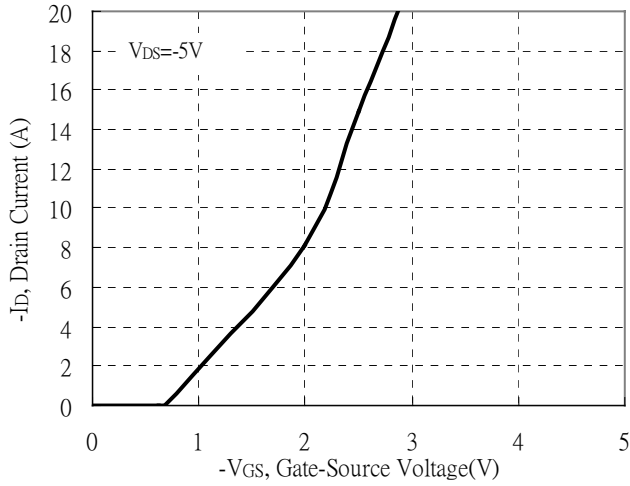
Maximum Drain Current vs Junction Temperature



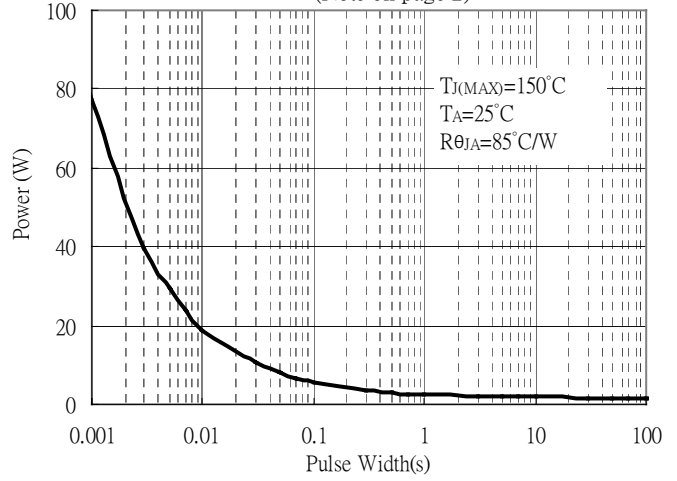


P-channel Typical Characteristics(Cont.)

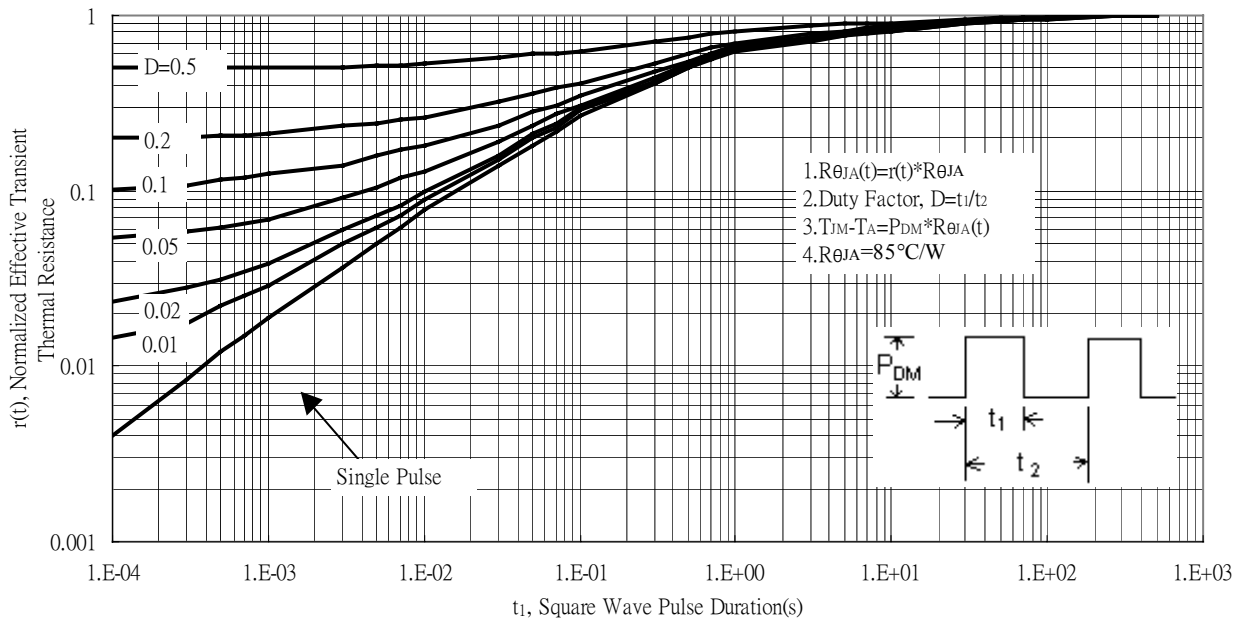
Typical Transfer Characteristics



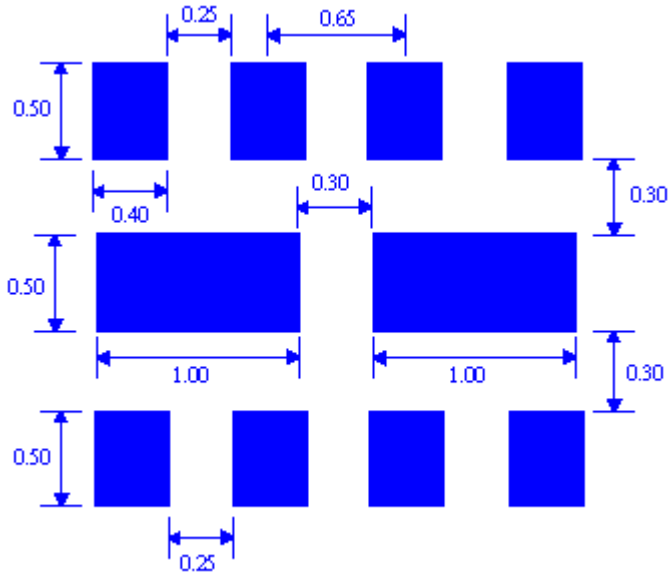
Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)



Transient Thermal Response Curves

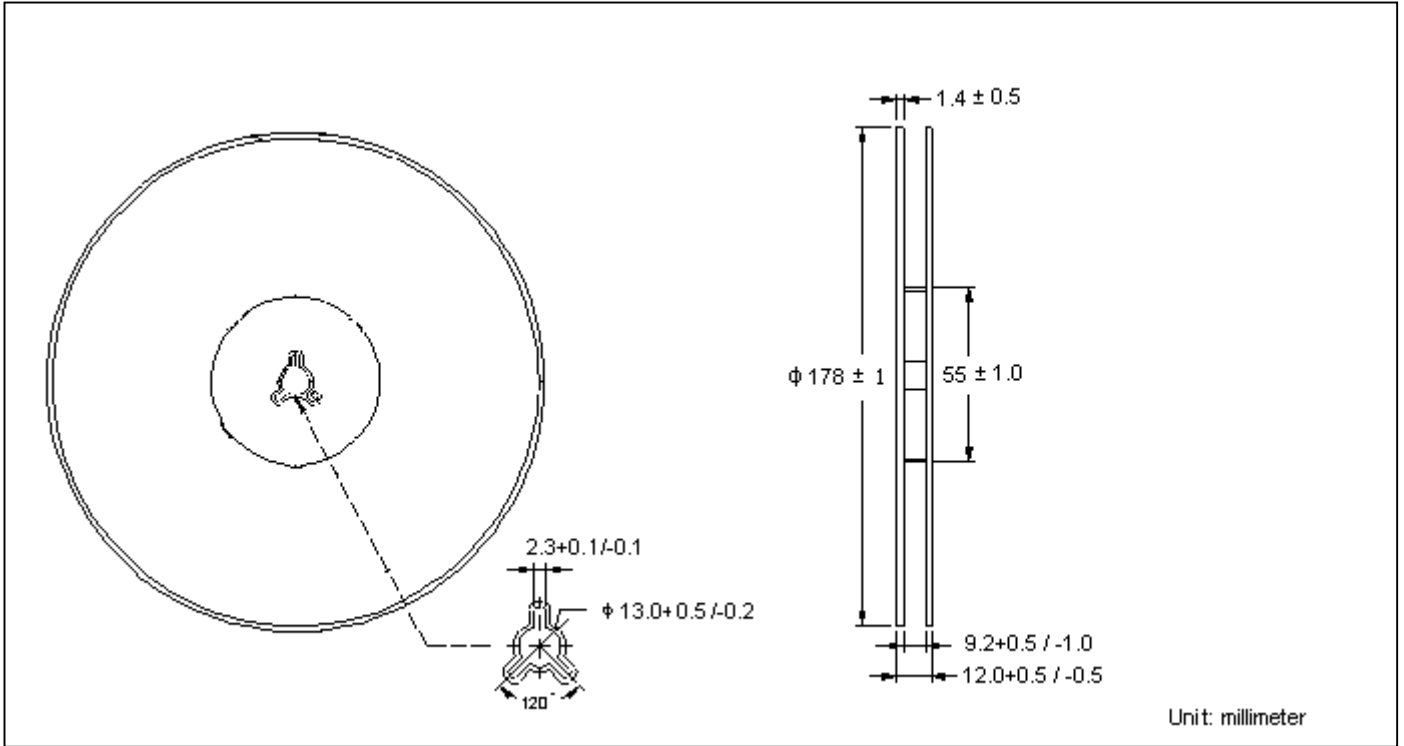


Recommended Soldering Footprint

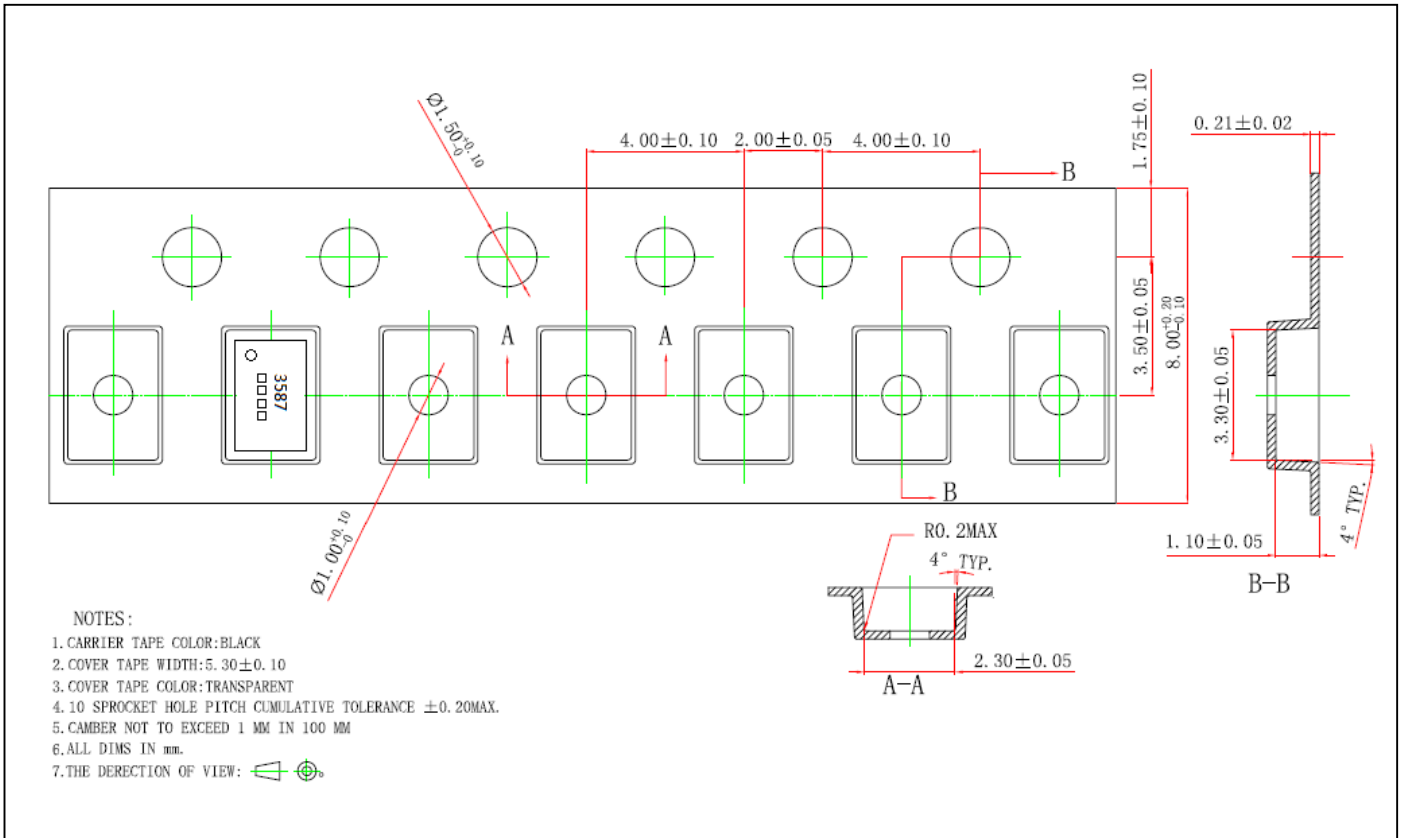


unit : mm

Reel Dimension



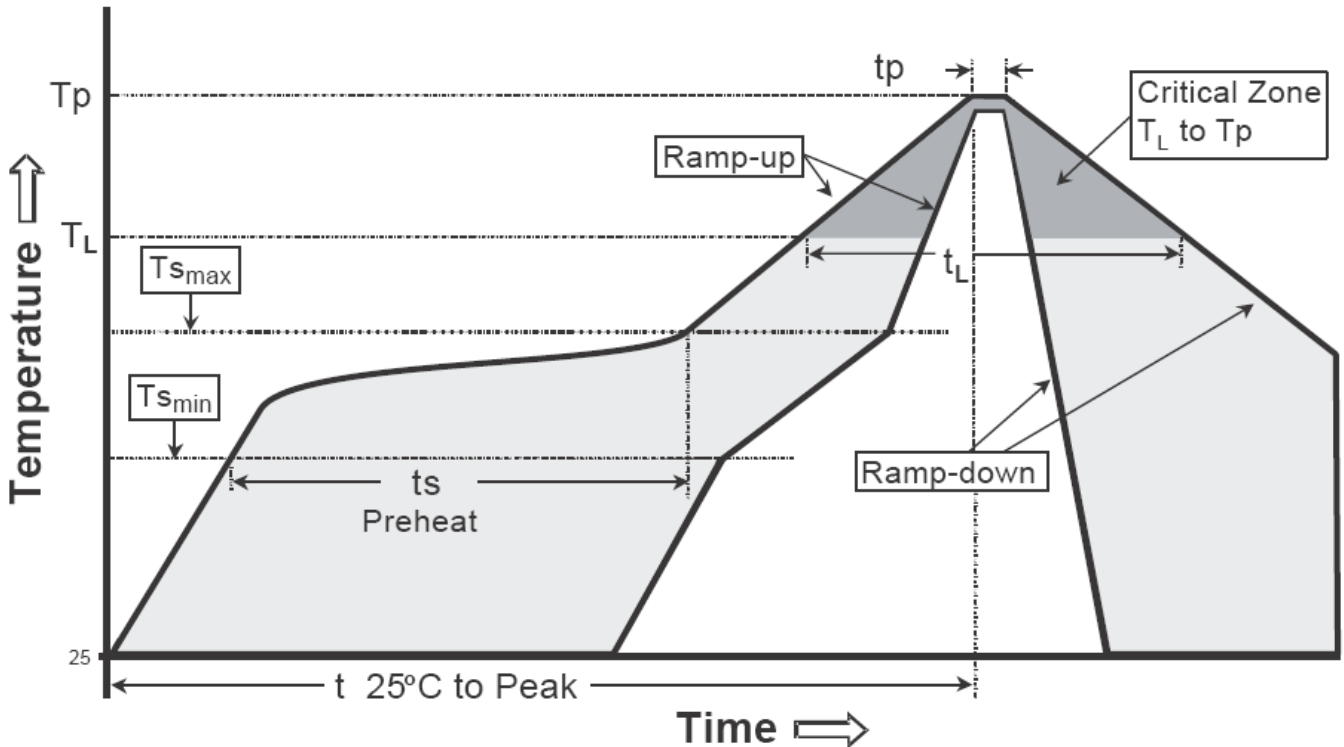
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

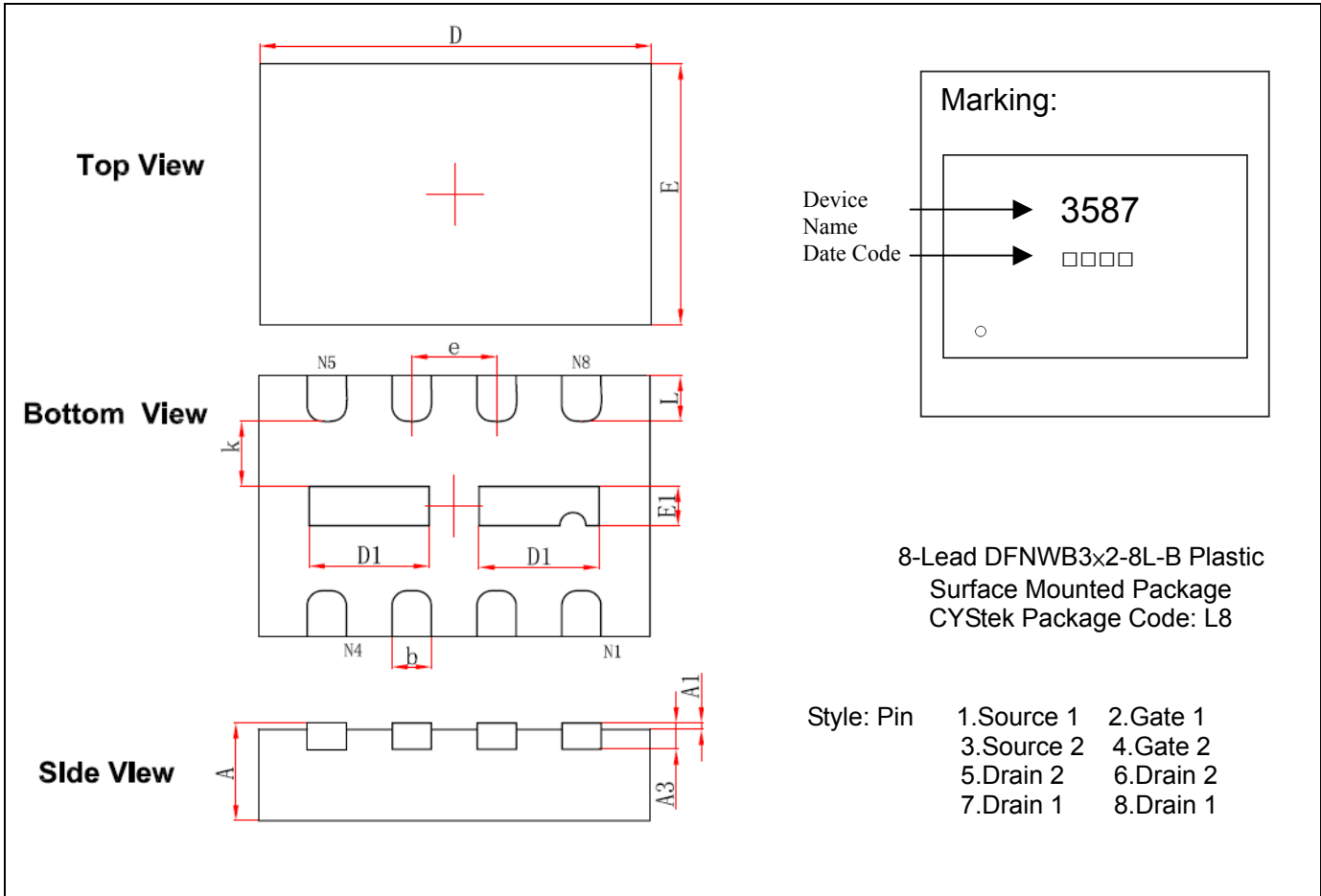
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

DFNWB3x2-8L-B Dimension



DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.700	0.900	0.028	0.035	E1	0.200	0.400	0.008	0.016
A1	0.000	0.050	0.000	0.002	k	0.200	-	0.008	-
A3	0.203	REF	0.008	REF	b	0.250	0.350	0.010	0.014
D	2.924	3.076	0.115	0.121	e	0.650	TYP	0.026	TYP
E	1.924	2.076	0.076	0.082	L	0.274	0.426	0.011	0.017
D1	0.820	1.020	0.032	0.040					

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

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